

Dual N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY

BV_{DSS}	20V
$R_{DS(on)(MAX.)}$	0.020Ω
I_D	8A

FEATURES

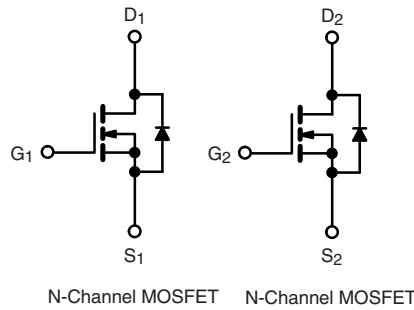
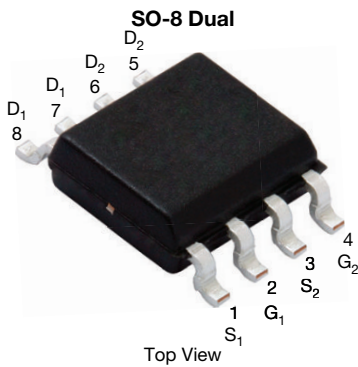
- TrenchFET® Power MOSFET
- 100 % UIS Tested
- 100 % R_g Tested

APPLICATIONS

- Set Top Box
- Low Current DC/DC



RoHS
COMPLIANT
HALOGEN
FREE



Absolute Maximum Ratings ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current@10V	I_D	$T_A = 25\text{ }^\circ\text{C}$	8
		$T_A = 100\text{ }^\circ\text{C}$	5.7
Pulsed Drain Current	I_{DM}	28	A
Total Power Dissipation	P_D	1.9	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	LIMIT.	Unit
Thermal resistance, junction-to-ambient	$R_{\theta JA}$	80	$^\circ\text{C} / \text{W}$

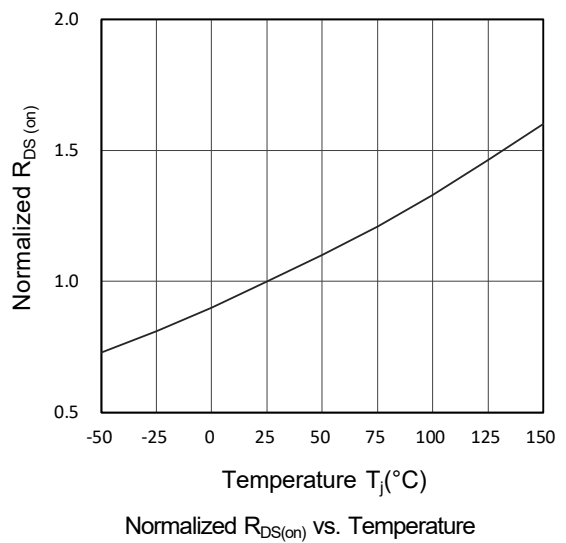
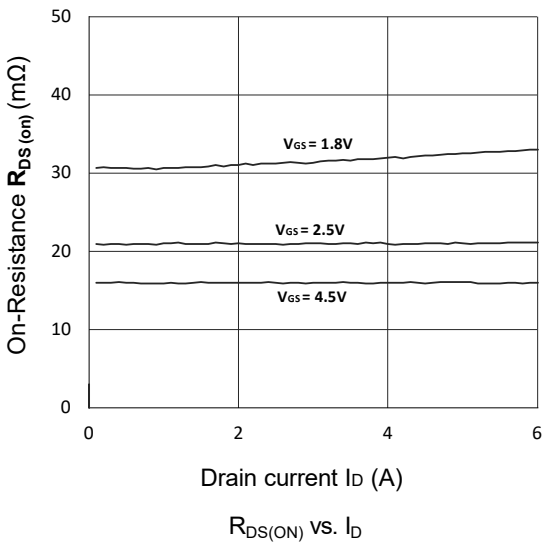
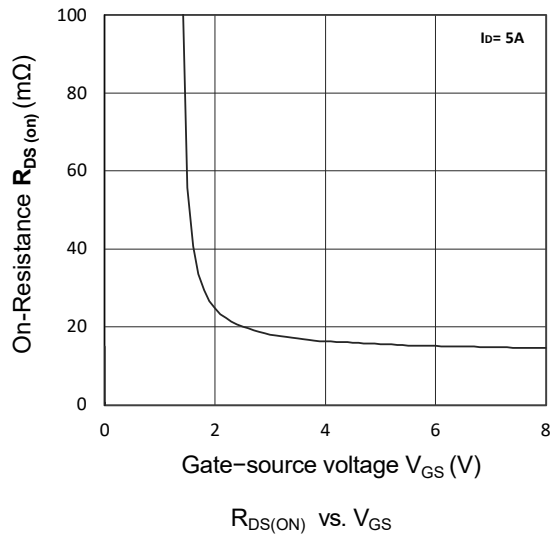
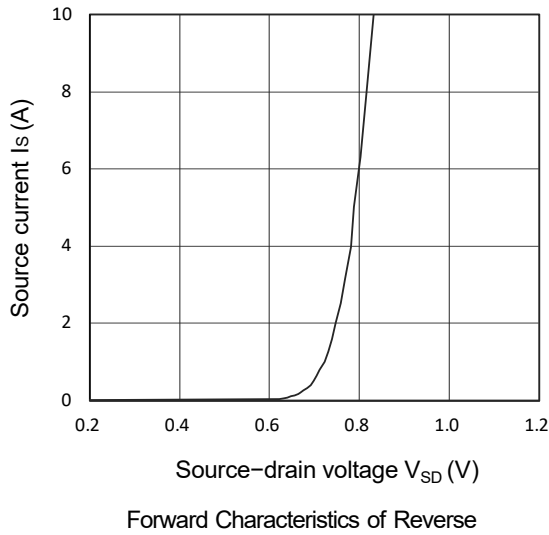
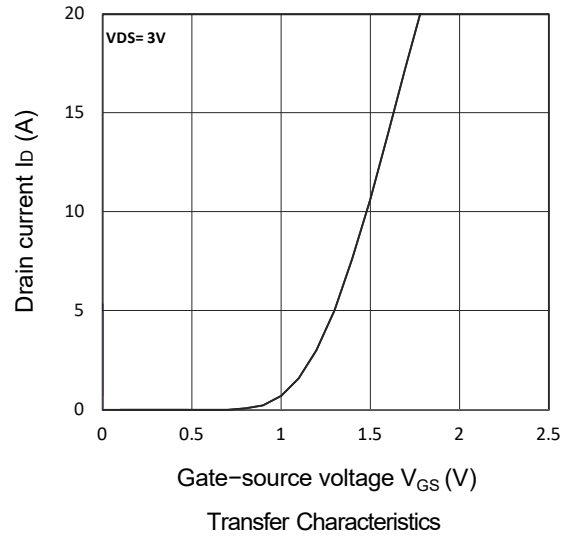
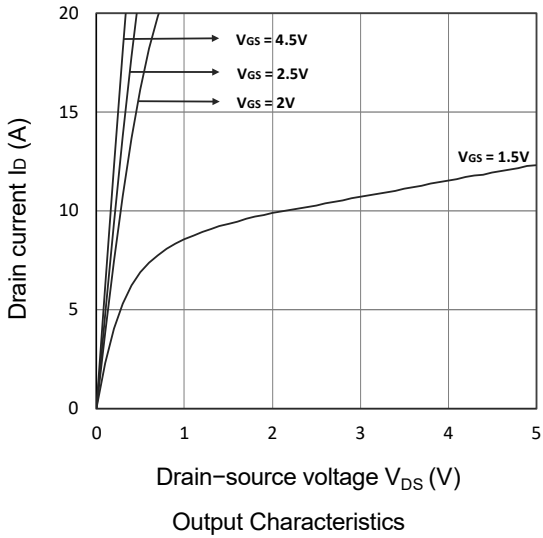
Electrical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$, $I_D = 250\ \mu\text{A}$	20	-	-	V
Gate-body Leakage current	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 12\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 25^\circ\text{C}$	-	-	1	μA
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$	0.4		1	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 4.5\text{ V}$, $I_D = 5\text{ A}$	-	0.014	0.020	Ω
		$V_{GS} = 2.5\text{ V}$, $I_D = 4.7\text{ A}$	-	0.021	0.030	
		$V_{GS} = 1.8\text{ V}$, $I_D = 4.3\text{ A}$	-	0.032	0.045	
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	-	702	-	pF
Output Capacitance	C_{oss}		-	122	-	
Reverse Transfer Capacitance	C_{rss}		-	107	-	
Switching Characteristics						
Total Gate Charge	Q_g	$V_{DS} = 10\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 5\text{ A}$	-	10.7	-	nC
Gate-Source Charge	Q_{gs}		-	2.2	-	
Gate-Drain Charge	Q_{gd}		-	2.7	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10\text{ V}$, $I_D \cong 5\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_G = 3\ \Omega$	-	12	-	nS
Rise Time	t_r		-	22	-	
Turn-Off Delay Time	$t_{d(off)}$		-	34	-	
Fall Time	t_f		-	12	-	
Drain-Source Body Diode Characteristics						
Diode Forward Voltage	V_{SD}	$I_S = 4\text{ A}$, $V_{GS} = 0\text{ V}$	-	-	1.2	V
Continuous Source-Drain Diode Current	I_S	$T_J = 25^\circ\text{C}$	-	-	8	A

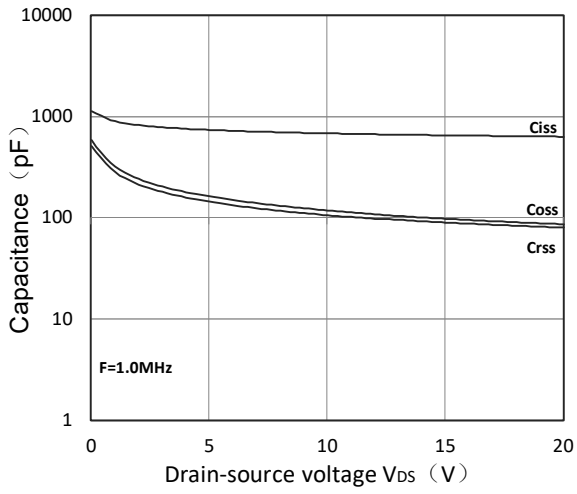
Notes:

- Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)} = 150^\circ\text{C}$.
- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- Pulse Test: Pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.
- This value is guaranteed by design hence it is not included in the production test

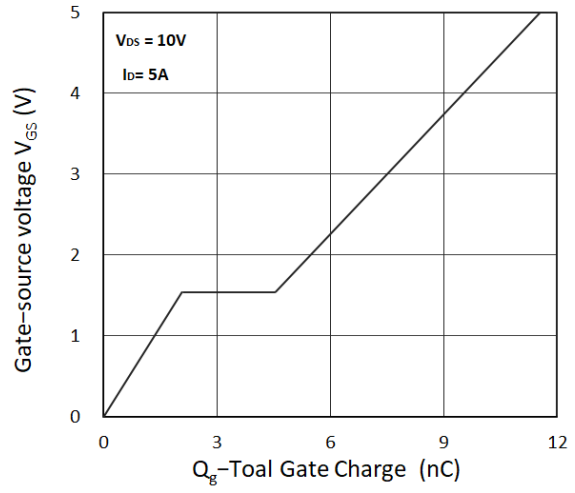
Test circuit and Waveform



Test circuit and Waveform

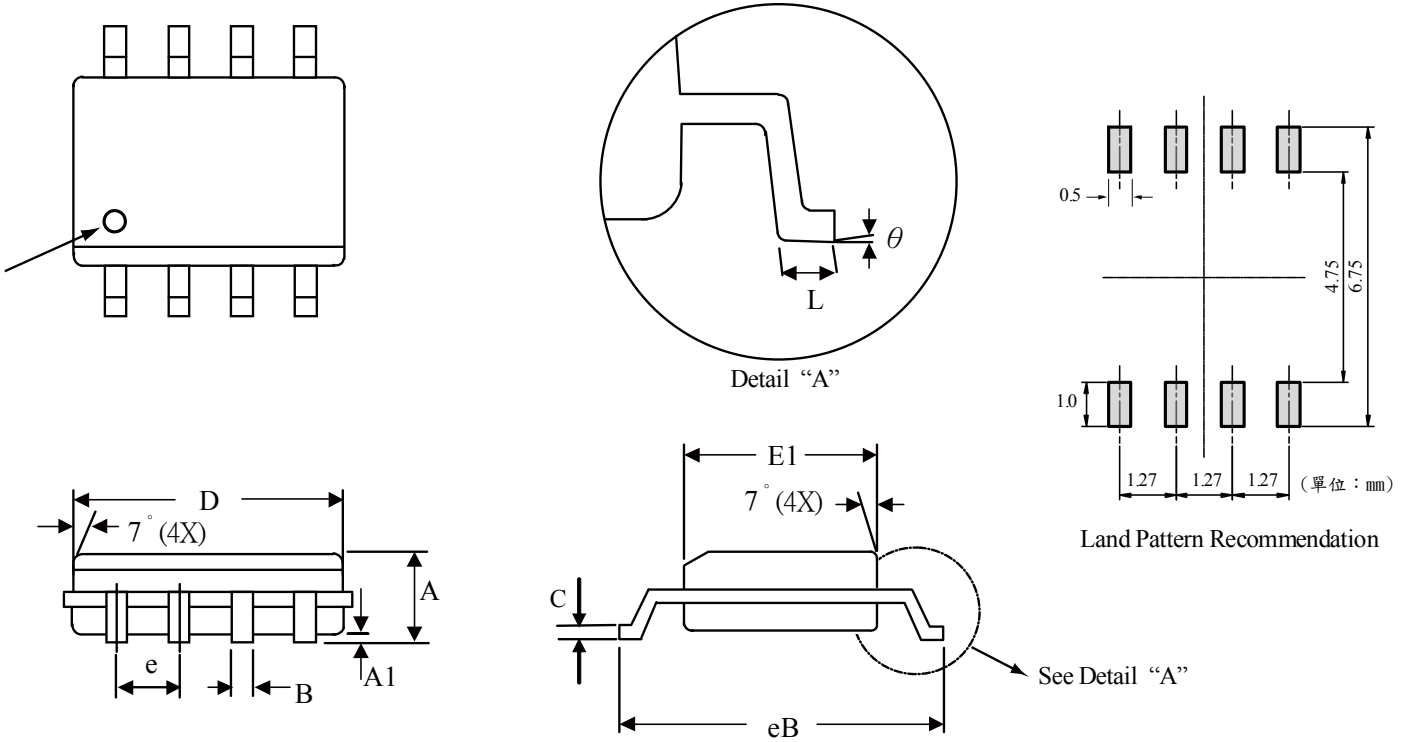


Capacitance Characteristics



Gate Charge Characteristics

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SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
B	0.31	0.51	0.012	0.020
C	0.17	0.25	0.007	0.010
D	4.69	5.00	0.185	0.197
E1	3.70	4.06	0.146	0.160
eB	5.80	6.20	0.228	0.244
e	1.27		0.050	
L	0.40	0.95	0.016	0.037
θ	0°		8°	